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CHARACTERIZATION AND SCATTERING OF BOUNDED
ULTRASONIC BEAMS

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Characterization and Scattering of Bounded Ultrasonic Beams


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ultrasonics, bounded beam, ultrasonic pulses, acousto-optics, backscattering, reflection at the Rayleigh angle.

An acousto-optic method is indicated with which to analyze the shape of an ultrasonic pulse. A mathematical model is given which describes a non-Gaussian bounded ultrasonic beam. Existing reflection formulations are used to predict the existence of backscattering at flat boundaries at the Rayleigh angle.
This Technical Report consists of reprints of papers which have appeared since July 1983, sponsored through Office of Naval Research Contract N00014-78-C-0584. The papers deal with some aspects of ultrasonic beam properties, their mathematical representation, and theoretical predictions related to reflection and scattering.

The first paper deals with an acousto-optic method by which the frequency contents of a pulsed ultrasonic signal can be determined without the introduction of a transducer probe whose presence in the path of the signal might alter the composition or shape of the pulse.

The second paper is concerned with reflection of an ultrasonic signal at a boundary, particularly with the recently mentioned possibilities of the existence of backscattering.

The third article deals with a method of describing mathematically a bounded beam which is known not to have a Gaussian cross section, and with the reflected profile of such a non-Gaussian beam.

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Washington, February 1984
Asymmetric light diffraction by pulsed ultrasonic waves

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Low-MHz, continuous ultrasonic waves traveling in a transparent medium cause light to be diffracted into discrete diffraction orders when light and sound propagation directions are normal to each other. When pulsed ultrasonic waves are used the diffraction orders split into secondary orders which are asymmetric with respect to the central diffraction order. This splitting is derived and a general expression provided for the intensity as a function of the ultrasonic pulse Fourier spectra. Examples are provided which demonstrate the degree of asymmetry for an exponential driving pulse and the convergence to the classic Raman–Nath results when the pulse approaches a continuous wave.

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INTRODUCTION

Optical probing of ultrasonic waves had its origins in 1932 through the independent observations by Debye and Sears1 in Washington and Lucas and Biquard2 in Paris that an ultrasonic beam in a liquid acts like a diffraction grating when illuminated by normally incident light. In 1935 Raman and Nath1–3 explained these observations by treating the ultrasonic beam as a moving phase grating. Their theory successfully predicted the diffracted light angular distribution and the relative intensities in the diffraction orders as a function of sound intensity, optical and ultrasonic wavelengths, and ultrasonic beam thickness.

Refinements of the Raman–Nath theory have been used to investigate a broad spectrum of theoretical and experimental conditions related to light diffraction by ultrasound. This has ranged from the theoretical investigation of light diffraction by superposed ultrasound by Murty4 to the use of optical probing for the investigation of the growth of higher harmonics in finite amplitude progressive waves by Zankel and Hiedemann5 and Breazeale and Hiedemann.6 Hargrove7 extended the Raman–Nath theory to include the prediction of the diffraction pattern for arbitrary ultrasonic waves as illuminated by Gaussian light beams. Zitter10 in turn applied this extended theory to light diffraction by symmetric short ultrasonic pulses. Other extensions have included the examination of light modulation by ultrasonic waves in the presence of amplitude optical gratings by Calligari et al.11–13

Our current interest is prompted by the recent experimental work of Häusler et al.,14 which demonstrated the production of structured diffraction patterns by pulsed ultrasonic waves and provided qualitative verification of the pulsed diffraction theory presented by Zitter.10 This paper expands the examination of Raman–Nath diffraction by pulsed ultrasonic waves to include non symmetric pulses which are composed of modulated sinusoidal waves of wavelength \( \lambda_s \) with a pulse repetition interval \( \lambda_r \).

There are three primary results. First, for small values of the pulse Raman–Nath parameter, optical probing provides a direct technique for the relative measurement of the ultrasonic pulse amplitude spectra. Second, the splitting of the intensities in the first Raman–Nath diffraction order into satellite orders as discussed by Zitter also occurs for the central, second, third, etc., diffraction orders. A general expression is provided for the calculation of these intensities. Third, the intensity distribution within the diffraction orders is asymmetric, i.e., the intensity in the positive \( m \)th diffraction is not equal to the intensity in the negative \( m \)th order.

I. GENERAL THEORY

When a monochromatic light beam of frequency \( f \), wavelength \( \lambda \), and width \( 2l \), is normally incident on an ultrasonic beam of diameter \( D \), frequency \( f_0 \), and wavelength \( \lambda_0 \), the amplitude distribution of the light in the farfield is given by the diffraction integral as

\[
A(\theta, t) = C e^{i\omega t} \int_{-\infty}^{\infty} e^{i\omega t} \sin \theta e^{i\kappa x} dx,
\]

where

\[
\begin{align*}
C &= \text{the normalization constant} \\
\omega &= 2\pi f \\
k &= 2\pi/\lambda \\
\theta &= \text{the farfield angle} \\
t &= \text{time} \\
\omega_0 &= 2\pi f_0 \\
k_0 &= 2\pi/\lambda_0 \\
\alpha &= \omega_0 - k_0 x ,
\end{align*}
\]

with \( \omega(\alpha) \) representing the phase change in the light wave front due to the ultrasonic wave. For a continuous wave excitation

\[
\omega(\alpha) = \nu \sin(\alpha),
\]

with

\[
\nu = 2\pi D/\lambda
\]

defined as the Raman–Nath parameter where \( \mu \) is the max-
imum variation of the media refractive index. For an arbitrary pulsed ultrasonic wave with functional form \( f(x,t,t_p) \) where \( t_p \) is the pulse repetition period, \( v \) can be expressed in terms of the Fourier expansion of \( f(x,t,t_p) \) as

\[
u(x_p) = \sum_{n=0}^{\infty} v_n \sin(n \alpha x + \phi_n),
\]

with

\[
\omega_p = \frac{2 \pi}{t_p},
\]

\[
\alpha_p = \omega_p - k_p x,
\]

\[
v_n = a_n v,
\]

\[
k_p = \omega_p / v
\]

\[v\] = ultrasonic velocity,

where \( a_n \) and \( \phi_n \) are the amplitude and phase of the \( n \)th Fourier component of the pulse. In this case \( \mu \) is determined by the pulse peak amplitude.

Substituting Eq. (4) into Eq. (1) and moving the dc component of \( \nu(x_p) \) outside of the integral yields:

\[
A(\theta, t) = C e^{i e x \sin \phi} \sum_{m} e^{i \nu_m^2} e^{i \nu_m^2} e^{i \nu_m^2}
\]

Using the identity\(^{10}\)

\[
e^{i e x \sin \phi} = \sum_{m} J_m(\nu) e^{i \nu m^2}
\]

the product expression in Eq. (5) can be rewritten as

\[
\prod_{m=1}^{\nu_n} \left( \sum_{m=-\infty}^{\infty} \nu_m e^{i \nu m^2} \right),
\]

where \( J_m(\nu) \) is the \( m \)th order Bessel function and

\[
\Psi_m = \sum_{r=1}^{\infty} \cdots \sum_{r_1=1}^{\infty} J_{r_1}(\nu_1) \cdots J_{r_n}(\nu_n) \cdots
\]

\[
\times \exp \left( i \left[ r_1(\nu_1) \cdots + \cdots r_1(\nu_n) \cdots \right] \right),
\]

with \( r_m(\nu) = m - 2r_1 \cdots - nr_n \cdots \). Substituting Eq. (7) into Eq. (5) and performing the integration yields:

\[
A(\theta, t) = \frac{C_i}{2} \sum_{m} \left( \psi_m e^{i (\omega + m \lambda) t + A_\theta \sin \frac{\Omega_m}{\Omega_m}} \right),
\]

with \( A_\theta = v_0 \sin \phi_0 \) and

\[
\Omega_m = (k \sin \theta - m k_p) \lambda
\]

Since the \( \psi_m \) terms are complex, Eq. (9) can be rewritten as

\[
A(\theta, t) = \frac{C_i}{2} \sum_{m} \left( \left( \psi_m e^{i (\omega + m \lambda) t + A_\theta \sin \frac{\Omega_m}{\Omega_m}} \right) \right)
\]

\[
- \psi_m e^{i (\omega + m \lambda) t + A_\theta \sin \frac{\Omega_m}{\Omega_m}} \right)
\]

\[
+ \psi_m e^{i (\omega + m \lambda) t + A_\theta \sin \frac{\Omega_m}{\Omega_m}} \right)
\]

\[
+ \psi_m e^{i (\omega + m \lambda) t + A_\theta \sin \frac{\Omega_m}{\Omega_m}} \right)
\]

Introducing the identity\(^{10}\)

\[
e^{i e x \sin \phi} = \sum_{m} J_m(\nu) e^{i \nu m^2}
\]

where \( \Psi_m^2 \) denote the real and imaginary components of \( \Psi_m \). The light intensity is then given by the square of the real part of Eq. (11).

\[
I(\theta, t) = \left| \text{Re} A(\theta, t) \right|^2.
\]

To obtain the measured response of a fast photodetector it is necessary to take the time average intensity over an interval \( \tau \) which is long compared to the period of the incident light and at the same time is short compared to the pulse repetition rate, i.e.,

\[
\bar{I}(\theta, t) = \frac{1}{\tau} \int_{t_o}^{t_o + \tau} I(\theta, t) dt,
\]

\[\omega = \frac{2 \pi}{\tau}, \partial \omega \approx \omega_p.
\]

Normalizing Eq. (13) to the peak light intensity in the absence of an ultrasonic wave, i.e., \( \theta = 0 \), \( \nu_m = 0 \) for \( m > 0 \), yields

\[
\bar{I}(\theta, t) = \sum_{m=0}^{\infty} \sum_{n=0}^{\infty} \sin \frac{\Omega_m}{\Omega_m} \sin \frac{\Omega_n}{\Omega_n}
\]

\[
\times, [\psi_n^m, \psi_n^m] \cos (m - n) \omega_p t_0
\]

\[
- \psi_n^m \psi_n^m \sin (m - n) \omega_p t_0
\]

\[
(7)
\]

\[
(10)
\]

\[
(11)
\]

which is independent of \( \nu_0 \). The same results could have been obtained by incorporating \( \nu_0 \) into the unperturbed media index of refraction. Due to the \( \sin x / x \) term in Eq. (14) the light intensity will exhibit maxima when \( \Omega_m = 0 \), i.e., at the angles \( \theta_m \) which satisfy the relationship

\[
\sin \theta_m = \pm m (\lambda / \lambda_p).
\]

Equation (15) is the same as the result obtained in continuous wave diffraction theory except that the diffraction angle is determined by the ratio of the incident light wavelength to the pulse spatial duration. Setting \( n = m - 1 \) and evaluating the product \( \sin \Delta \theta / \Delta \theta \) at the angle \( \theta = m \lambda / \lambda_p \) indicates that the diffraction orders will start to be resolvable when \( (2 \pi n / \lambda_p) > 1 \). Thus as the pulse repetition rate increases and the number of pulses within the illumination interval increases (i.e., \( 2 \pi n / \lambda_p \)), the light intensity will exhibit maxima when \( \Omega_m = 0 \), and the diffraction pattern becomes discrete, i.e.,

\[
\bar{I}(\theta, t) = \bar{I}(\theta) = \sum_{m=0}^{\infty} \left( \frac{\sin \frac{\Omega_m}{\Omega_m}}{\Omega_m} \right)^2 I_m,
\]

where

\[
I_m = (\psi_m e^{i (\omega + m \lambda) t + A_\theta \sin \frac{\Omega_m}{\Omega_m}})^2
\]

with \( I_m \) being the intensity in the \( m \)th diffraction order.

To illustrate the behavior of the diffracted light intensity as the ultrasonic pulse amplitude increases, \( \Psi_m \) can be factored into a series of approximate expressions based on successively higher Bessel function products, i.e., \( J_1, J_2, J_3, \cdots \), etc.

A. First-order approximation

To determine how the diffraction order intensities initially develop we can examine Eq. (17) in the limit that the \( \nu_m \) are small, i.e., products in \( \Psi_m \) of order \( J_k(\nu_k \nu_k) \) or higher vanish. Using this constraint and the relationship

\[
m = r_1 + 2r_2 + \cdots + nr_n + \cdots,
\]

used in the definition of \( \Psi_m \), we find that for \( m = 0 \)

\[
I_0 = \left| \prod J(\nu_k) \right|^2
\]

and for \( |m| > 0 \),
\[ I_{\pm m} = \left| \sum_{n=\pm m} J_{\pm 1}(v_n)e^{\pm i\theta_n} \prod_{k=m+2} \frac{J_0(v_k)}{J_{\pm 1}(v_k)} \right|^2. \]  

(20)

Since \[ I_{m} = I_{-m}, \]

the diffraction pattern is symmetric about the central order. In the very small amplitude limit \[ \theta_0 \approx 1.0 \]

and \[ I_{\pm m} \approx \nu_0^2/4. \] Thus the intensities in the individual diffraction orders provide a relative measure of the ultrasonic pulse's Fourier amplitude spectra.

\[ I_{\pm m} = \left| \sum_{n=\pm m} J_{\pm 1}(v_n)e^{\pm i\theta_n} \prod_{k=m+2} \frac{J_0(v_k)}{J_{\pm 1}(v_k)} \right|^2. \]  

(21)

with the convention that all terms vanish with noninteger summation indices and when the indices of the \( v_n \) are equal and that the summations and \( \Pi \) products are valid only over positive nonzero index values. The upper sign in the expression corresponds to the positive diffraction orders and the lower sign corresponds to the negative orders.

Since \( J_{-m}(x) = (-1)^m J_m(x) \), the second-order terms in (21), \( J_2(v_{m+2}) \) and the two \( J_1J_1 \) product expressions, experience a 180° phase shift relative to \( J_1(v_n) \) in going from \( +m \) to \( -m \). If these terms represent a net increase in amplitude when added to \( J_1(v_m) \), there will be a corresponding net decrease when added to \( J_{-1}(v_m) \). This causes the diffraction pattern to become asymmetric.

We can use Eq. (21) to illustrate the mechanisms involved in the growth of the farfield diffraction pattern. Based on Eq. (15), each diffraction order corresponds to a multiple of the pulse repetition rate \( \omega_p \). The first term in Eq. (21) represents the first Raman–Nath diffraction order for the \( m \)th Fourier component of the pulse. The second term represents the second Raman–Nath diffraction order of the \( m/2 \)th pulse Fourier component. The \( J_1J_1 \) and \( J_2J_{-1} \) summations correspond to the mixing of the contributions of the pulse Fourier components, i.e., the sum and difference terms which result in \( m\omega_0 \). The resultant farfield diffraction pattern is the superposition of the Raman–Nath diffraction patterns of the pulse Fourier components and the mixing of these components as constrained by Eq. (18).

In the continuous wave limit all Fourier components of \( v \) vanish except for the \( v_0 \) which corresponds to the pulse fundamental frequency. The resulting intensities \[ I_0 = J_0(v_n), I_{\pm m} = J_1(v_n), \] and \( I_{2m} = J_2(v_n) \) correspond to the zero, first, and second Raman–Nath diffraction orders.

The next highest approximation adds \( J_1J_1J_1J_1 \) and \( J_1J_1J_2J_{-1} \) terms to the expression for the intensity. In the interest of brevity only the additions to Eq. (19) and Eq. (21) are shown with the phase and \( \Pi \) product expressions suppressed. In each case the additions are to the terms inside the absolute value signs. The central order is given by

\[ I_0 = \left| \text{Eq. (19)} + \sum_{n=m} \left( J_{-2}(v_n)V_1(v_n) + J_2(v_n)V_{-1}(v_n) \right) \right|^2 \]

(22)

with the convention that all terms vanish with noninteger summation indices and when the indices of the \( v_n \) are equal and that the summations are valid only over positive nonzero integer values. The change for the higher orders (\(|m| > 0\)) is given by

\[ I_{\pm m} = \left| \text{Eq. (21)} + \sum_{n=m} J_{\pm 2}(v_n)V_{\pm 1}(v_n) + \sum_{n=m+2} J_{\pm 2}(v_n)V_{\pm 1}(v_{n+2}) \right|^2 \]

(23)
using the same conventions as were imposed on Eq. (21). Since \( J_{-n}(x) \) equals \((-1)^nJ_n(x)\), the \( J_{2m} \) and \( J_{2m+1} \) expressions maintain a constant phase relationship with \( J_n(v_0) \) in going from \(+m\) to \(-m\). As a result, the associated increase or decrease in amplitude for the \(+m\) and \(-m\) orders is the same. In the continuous wave limit when all components of \( v \) vanish except \( v_0 \) the diffracted light intensities become \( I_0 = J_0(v_0) ; I_{\pm n} = J_{\pm 1}^2(v_0) ; I_{\pm 2n} = J_{\pm 2}^2(v_0) \) and \( I_{\pm 3n} = J_{\pm 3}^2(v_0) \). These correspond to the zero, first, second, and third Raman-Nath diffraction orders. Higher order terms will impact on the asymmetry in the diffraction pattern only if the sum of the Bessel function orders is even.

II. ANALYTIC RESULTS

This section provides examples of the diffracted light intensity distribution as a function of \( v \) and the growth and decay of asymmetries within the diffraction pattern. For illustration the exponentially damped sinusoid given by Eq. (24) is used as the pulse time history.

\[
v(t) = v_0 e^{-a/\omega_0} \sin \omega_0 t [h(t) - h(t - \pi/\omega_0)] e^{1/\omega_0},
\]

where \( h(t) \) is the Heaviside function, \( \omega_0 = 2\pi f_0 \) and \( k_1 \) and \( k_2 \) determine the pulse decay and repetition rates. In this form a pulse with \( k_1 = 10.0 \) and \( k_2 = 30.0 \) has an e-folding time of 10\( \tau_0 \) and a repetition rate of 30\( \tau_0 \) where \( \tau_0 = 1/\omega_0 \). The Fourier amplitudes of \( v \) are \( v_\alpha = v_0 \alpha_n \) with \( \alpha_n = (c_n^2 + b_n^2)^{1/2} \) and \( \alpha_n \) given by

\[
c_n = \left( \frac{\alpha_n - e^{-\alpha} [\Delta \sin \alpha_n + \alpha_n \cos \alpha_n]}{\Delta^2 + \alpha_n^2} \right)
+ \frac{\gamma_n - e^{-\alpha} [\Delta \sin \gamma_n + \gamma_n \cos \gamma_n]}{\Delta^2 + \gamma_n^2} e^{1/\omega_0},
\]

\[
b_n = \left( \frac{e^{-\alpha} [\alpha_n \sin \alpha_n + \Delta \cos \alpha_n] + \Delta}{\Delta^2 + \alpha_n^2} \right)
- \frac{e^{-\alpha} [\gamma_n \sin \gamma_n - \Delta \cos \gamma_n] + \Delta}{\Delta^2 + \gamma_n^2} e^{1/\omega_0},
\]

where \( \Delta = k_2/k_1 \), \( \alpha_n = 2\pi(k_2 - n) \), and \( \gamma_n = 2\pi(k_2 + n) \). The phase \( \phi_n \) is given by \( \arccos(c_n/\alpha_n) \) with the sign of \( \phi_n \) determined by the quadrant within which \( c_n \) and \( b_n \) fall.

Figure 1 illustrates the amplitude and phase spectra of Eq. (24) when \( k_1 = 10.0 \) and \( k_2 = 30.0 \). For \( f_0 = 3.0 \) MHz the spectral components are spaced 100 kHz apart, the maximum amplitude occurs at 3.0 MHz, and the components above and below 3.0 MHz are approximately \( \pi/2 \) out of phase with a slight asymmetry in the amplitude spectra.

A. Farfield diffraction patterns

Using the spectra presented in Fig. 1 we can now examine the growth of the diffraction pattern as a function of the Raman-Nath parameter. This is shown in Fig. 2 based on Eqs. (22) and (23) for selected values of \( v \) with an arbitrary intensity cutoff set at 0.1\%, i.e., 1E-3, on the abscissa. In each part of Fig. 2, the diffraction orders are shown with the expected relative spatial separation. Initially when \( v = 0.5 \) [Fig. 2(a)], the central order has no satellite orders above the threshold and the pattern is almost symmetric. The positive and negative diffraction orders \( I_{\pm 2n} \) through \( I_{\pm 3n} \) locally follow the asymmetry which exists in the amplitude spectra [Fig. 1(a)]. As the pulse amplitude increases the second-order sum and difference terms previously discussed begin to introduce asymmetries into the pattern. At \( v = 1.0 \) [Fig. 2(b)] the local asymmetry in the satellite orders around \( I_{\pm 10} \) has decreased at the same time that the asymmetry in the satellite orders around \( I_{\pm 30} \) has started to increase. As the second-order terms continue to increase in magnitude the pattern becomes locally asymmetric around \( I_{\pm 30} \) [Fig. 2(c)], the asymmetry between the positive and negative orders becomes more pronounced, and the satellite orders begin to appear locally about the central order. The asymmetry in \( I_{\pm 1} \) through \( I_{\pm 3} \) results from the \( J_{\pm 1} \) terms in Eq. (21) being the same order of magnitude as \( J_{\pm 3} \). As the pulse amplitude continues to increase [Fig. 2(d)], the local asymmetry around the central order decreases as the asymmetry increases around \( I_{\pm 30} \). At \( v = 2.5 \) [Fig. 2(e)], the number of satellite orders around the central order has increased at the same time that some of the satellite orders about \( I_{\pm 30} \) have dropped below the intensity threshold.
II. Discussion of successive approximations

The contributions of the approximations in Eqs. (20)–(23) to the farfield diffraction pattern presented in Fig. 2 are illustrated in Fig. 3 as a function of v. The first approximation Eq. (20) is given by the dotted line, the second approximation Eq. (21) by the dashed line, and the third approximation Eq. (23) by the solid line. For $I_{2p}$, Eqs. (20) and (21) are approximately equal and Eq. (23) results in a small correction to the intensity. The apparent divergence of the approximations for $I_{2p}$ and $I_{3p}$ can be understood by examining the relative magnitudes of the individual contributions to the amplitude of the diffracted light intensity. For $v = 2.0$ and
m = 29 the leading terms in the series approximations, Eqs. (20)–(23), excluding the phase and product expressions are

\[ J_1(v_{29}) \] for the satellite orders vanish as shown in Fig. 3. Based on the examination of Eqs. (20) and (23) it is apparent that \( J_0(v_m) \) for decreasing \( m \) drops in magnitude more rapidly than the leading terms for the higher approximations. Also, approximations beyond those presented in Eq. (23) will produce second-order corrections to the intensity over the range of interest. For \( v > 1.0, m < 28 \) or \( m > 28 \) become dominated by the product terms that correspond to the frequency associated with the order. For \( v > 3.0 \) higher order approximations \( (J_{2v}, J_{2v}, \ldots) \) will begin to produce first-order corrections to the intensity.

The development of asymmetries in the associated negative orders is shown in Fig. 4. As expected the contributions of the \( J_{2v} \) and \( J_2 \) terms in Eq. (21) which add to \( J_{30} \) (Fig. 3) result in an equivalent reduction in \( J_{-20} \) (Fig. 4). Concurrently the higher order terms in Eq. (23) produce a reduction in both the positive and negative order intensities.

C. Continuous wave limit

In the limit that the pulse approaches a continuous wave the satellite orders vanish as shown in Fig. 5 for the central order \( (v = 2.0) \). As \( k \) increases the pulse amplitude spectra approaches \( v_m = 1.0 \) for \( m = 30 \) and \( v_m = 0.0 \) for \( m \neq 30 \). This causes \( J_0(v_m) \) to decrease more rapidly than the \( J_{-1}(v_m) \) terms locally around \( v_{30} \). The pattern becomes symmetric locally about the central order and then vanishes as the central order intensity approaches \( J_0(2) \).

III. EXPERIMENTAL RESULTS

To provide qualitative verification of the theory presented in Sec. I, an Arenberg pulser was used to excite a PZT transducer with a short pulse (3.0-MHz fundamental frequency). The resulting farfield diffraction pattern from a sequence of pulses is shown in Fig. 6 for a pulse duration of \( \sim 4 \) \( \mu \)s, a repetition rate of \( \sim 32 \) \( \mu \)s, and a Raman–Nath parameter of \( \sim 3.0 \). As predicted by the theory the splitting occurs in the central diffraction order and local symmetry appears around \( J_{-40} \), the order associated with the pulse fundamental frequency. There is no discernable asymmetry for the satellite orders about the central order as would be expected for \( v \sim 3.0 \) due to the dominance of the \( J_{2v}, J_{-1} \) terms in Eq. (21).
IV. SUMMARY

An analytic expression has been derived for the Raman–Nath diffraction by pulsed ultrasonic waves which can be applied to any general pulse shape amenable to spectral analysis. In general the resulting diffraction pattern is asymmetric around the central order with the degree of asymmetry dependent on the spectral composition of the pulse. A limited set of examples has been provided which demonstrates the degree of asymmetry for an exponential driving pulse and the convergence to the classic Raman–Nath results when the pulse approaches a continuous wave.

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Theoretical prediction of a backscattering maximum at Rayleigh angle incidence for a smooth liquid-solid interface

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A numerical integration method for the description of acoustic bounded beams is used to calculate possible backscattering strength from a smooth liquid-solid interface. It is shown that the backscattering strength is maximum for Rayleigh angle incidence. The influence of beam shape and beamwidth on the backscattering strength near the maximum is demonstrated.

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INTRODUCTION

Recently, an interesting phenomenon associated with the backscattering of a bounded acoustic beam from a smooth liquid-solid interface has been reported. This phenomenon involves the existence of a relative maximum at the Rayleigh angle incidence when the backscattering strength is measured for various incident angles. First, de Billy, Adler, and Quentin reported on this maximum in backscattering strength for a water-stainless steel and a water-copper interface. The same authors later considered this phenomenon in the backscattering of a bounded acoustic beam from a through layered interface. The same authors later considered this phenomenon in the backscattering of a bounded acoustic beam from a through layered interface. The same authors later considered this phenomenon in the backscattering of a bounded acoustic beam from a through layered interface.

Theoretical prediction of a backscattering maximum at Rayleigh angle incidence for a smooth liquid-solid interface was initially developed by Ngoc and Mayer to describe acoustic bounded beams reflected from or transmitted through layered media. As will be shown in the following calculation results, this theoretical analysis is able to describe the general features of backscattering strength as a function of incident angle, including the relative maximum at the Rayleigh critical angle.

I. THEORY AND COMPUTATIONAL RESULTS

Following the formulation developed by Ngoc and Mayer, the spectral representation is again invoked to describe the scattered field of an acoustic bounded beam of frequency \( \omega \) incident into a smooth liquid-solid interface at an incident angle \( \theta_i \),

\[
U(x,z) = (2\pi)^{-1} \int_{-k}^{k} R(k_x) V(k_x) \exp[i(xk_x + zk_z)] dk_x. \tag{1}
\]

The symbols used in above equation are defined as follows: \( U(x,z) \) is the acoustic scattered field in the \((x,z)\) plane assuming uniformity in the \(y\) dimension; \( k \) is the wave vector in the liquid; \( k_x \) and \( k_z \) are the \(x\) and \(z\) components of the \(k\) vector related by \( k_z = (k^2 - k_x^2)^{1/2} \). The quantity \( R(k_x) \) denotes the plane-wave reflection coefficient at a liquid-solid interface (e.g., see Ref. 8) and \( V(k_x) \) is the Fourier transform of the incident acoustic beam given at the interface, describing the complex amplitude of the constituent plane waves that form the incident beam.

In calculating the scattered sound field the integral of Eq. (1) is interpreted as describing the scattered field represented by a superposition of plane waves having the complex amplitude \( R(k_x)V(k_x) \). Integrating from \(-k\) to \(k\) implies that contributions to the scattered field can come from plane waves reflected in all directions from this interface. To be compatible with most experimental arrangements, transducers of finite size for both acoustic source and detector will be taken into account in the present study. In addition, one would also like to be able to account for the specific response pattern of the detector in use. The scattering geometry adopted in the following computations is illustrated in Fig. 1. The source and detecting transducers, both having a width...
FIG. 1. Schematic description of the scattering geometry under consideration.

of $2\omega$, are rotated on semicircular paths of radius $d$. The incident and detecting angles are defined as $\theta_i$ and $\theta_d$, respectively. The positive direction of these angles is indicated by the underlying arrows and therefore detection of the backscattered sound would assume a negative value for $\theta_d$. For the backscattering geometry, $\theta_d = -\theta_i$.

In the backscattering calculations to be presented, the incident beam profile is taken to be a finite Gaussian one and the detecting transducer is assumed to have a flat response. The calculations are carried out according to the following procedure:

(a) For a given $\theta_i$, the incident beam profile is first projected onto the $z = 0$ interface;

(b) The projected incident profile is then Fourier transformed to yield $V(k_z)$;

(c) Interaction of individual plane waves of complex amplitude $V(k_z)$ with the interface is described by the product $R(k_z)\overline{V}(k_z)$, which is now entered into the integrand of Eq. (1);

(d) The scattered acoustic field at spatial position $(x,z)$ can now be evaluated by an exact numerical integration of Eq. (1) across the surface of the detecting transducer, which can be represented by

$$x = \tan \theta_d(d - x)$$

for

$$d \sin \theta_d = w \cos \theta_d < x < d \sin \theta_d + w \cos \theta_d;$$

(2)

(e) The backscattering strength for a given $\theta_d = -\theta_i$ is finally determined from the scattered field calculated across the detecting surface in the preceding step by averaging them according to the selected response of the detector.

Figure 2 presents the first set of computational results showing backscattering strength as a function of incident angle for three values of beamwidth, $2\omega = 5$, 10, and 20 mm, with an acoustic source of 2 MHz. These computations are done for a water–stainless steel interface with the radial distance $d$ being 50 mm. The backscattering strength curves shown in Fig. 2 exhibit a steady decrease as the incident angle becomes larger, with a distinct relative maximum positioned approximately at the Rayleigh critical angle which is calculated to be 30.65° in this case. Near the relative maximum one observes that the maximum peak increases with beamwidth and the slope of the maximum is broadened at the base for smaller beamwidths.

Next, the beamwidth is kept constant at the value of 10 mm but the shape of the incident Gaussian profile is varied. This is achieved by introducing a parameter $\alpha$ in the expression describing a Gaussian profile,

$$U_{inc}(x) = \exp(-[(x/\alpha \omega)^2]).$$

(3)

Setting $\alpha = 1$ corresponds to the incident profile used in the previous set of calculations. In the present set of calculations, the incident beam generated by setting $\alpha = 0.5$ has a narrower profile while $\alpha = 2.0$ results in a broader profile. These incident profiles are illustrated in Fig. 3.

Again, the above computational procedure is applied to calculate the backscattering strength versus the incident angle for the three incident profiles shown in Fig. 3. The results are presented in Fig. 4 where the steady decrease, interrupted by a relative maximum near the Rayleigh angle, is observed for all of these profiles. The most noticeable difference among them is that the relative maximum is consider-
identified two key parameters that would affect the backscattering strength as a function of the incident angle. These two parameters are beamwidth and profile shape of the incident beam. It is expected from this formulation that other parameters including response pattern of the detector and distance of source and/or detector from the interface would also strongly influence the backscattering strength.

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NONSPECULAR EFFECTS FOR A FINITE INCIDENT BEAM MODELED BY AN EVEN-ORDERED POLYNOMIAL

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Nonspecular Effects for a Finite Incident Beam Modeled by an Even-Ordered Polynomial
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Abstract - The reflection of non-Gaussian ultrasonic beams, expressed in terms of an even-ordered polynomial, is discussed and it is shown that at critical longitudinal and Rayleigh angles of incidence deviations from the Gaussian profile case occur, varying with the polynomial representation chosen. Examples are given for water–Plexiglas and water–stainless steel flat interfaces.

INTRODUCTION

Nonspecular reflection and transmission effects of a finite sound beam have been investigated [1]–[7] for various types of layered media. Bertoni and Tamir's analysis [1] described these effects at the Rayleigh critical angle for a liquid–solid interface. Pitts et al. [2] extended Bertoni and Tamir's approach to another structure in which a solid plate is immersed in a liquid medium. This approach again was able to describe nonspecular effects at the critical plate-mode angles associated with Lamb waves of the solid plate. The problem was generalized to incorporate sound attenuation in the media and was solved numerically by Ngoc and Mayer [3]–[6]. This led to a description of nonspecular reflection and transmission effects at all incident angles where these effects may occur. The numerical approach enabled the discovery of nonspecular effects at the longitudinal critical angle [3] of the liquid–solid structure and at the between-mode angles [5] of the liquid–solid–liquid structure in addition to those taking place at the Rayleigh angle and the critical plate-mode angles of the respective structures. It was also able to describe the variation of nonspecular features as the incident beam was steered away from the critical angles.

The results of these studies provided an adequate understanding of the physical processes that underlie the nonspecular effects taking place upon reflection from or transmission through a flat interface. However, a major deficiency of the above theoretical models that limits the application of these effects to practical problems rests with the fact that these analyses are all based on the assumption of an incident beam having a Gaussian intensity distribution.

In most practical situations where one finds a sound beam incident at an interface, the incident beam profile would invariably be non-Gaussian. This is due to the fact that all acoustic beams traveling in any kind of medium must be subjected to several mechanisms that will distort the beam patterns [8], [9]. Such mechanisms include, for example, nonlinear interaction, absorption, geometrical diffraction, and dispersion of the medium itself. These mechanisms would sometimes change the beam pattern produced by the transducer by enhancing or reducing the side lobes. It is therefore quite desirable to be able to understand how an incident beam with side lobes be-
haves after interacting with an interface. In addition, one would also like to know if sidelobes are generated as part of non-specular reflection or transmission of a non-Gaussian incident beam. As a result one can distinguish the changes in beam profile due to the non-specular effects from those produced by the above-mentioned mechanisms associated with the medium.

In general, the current theoretical models describing non-specular effects would become more useful if they allowed for treatment of incident beams of an arbitrary intensity distribution. In this paper, the numerical approach developed for Gaussian incident beam will be modified to investigate the non-specular effects for incident beams having an nth-order polynomial intensity distribution. The choice of the polynomial distribution was motivated by the consideration that polynomial distributions can approximate very well many transducers in current use; furthermore, they can be adapted to be used as basic components to construct an arbitrary intensity distribution. In the following, modifications to the theoretical framework will be illustrated and sample non-specular reflected beam profiles computed from the modified theory will be presented.

**Theoretical Formulation**

Consider a finite beam bounded in the (x, z) plane and uniform in the y-dimension, of angular frequency \( \omega = 2\pi f \) and beam width 2w. A spectral representation of such a bounded beam treats it as a superposition of an infinite number of plane waves having the same frequency but different amplitude and incident at slightly different angles about a central direction indicated by \( \theta_i \). Extending the principle of spectral representation to a reflected or transmitted bounded beam one can describe the reflected or transmitted field distribution by

\[
U(x, z) = (2\pi)^{-1} \int_{-\infty}^{\infty} \int_{-\infty}^{\infty} \mathcal{P}(k_x) V(k_x) \exp \left[ ikx + zk_z \right] dk_x \text{.} k_z = k \sin \theta_i
\]

where \( \mathcal{P}(k_x) \) is the plane wave reflection or transmission coefficient for the layered structure under consideration. As before [5], \( V(k_x) \) is the Fourier transform of the incident field and \( w_0 = w/\cos \theta_i \) and \( k = k \sin \theta_i \).

The present study investigates an incident beam described by an nth-order polynomial and compares the computational results with those for a Gaussian incident beam. Since most sound beams in practice are symmetric only the even orders of incident profile given by (1) are considered. The specific form of the polynomials used to model the incident beam in this study are taken to be

\[
U_{2n}(x, 0) = \begin{cases} A_{2n} [1 - (x/w_0)^2]^n, & -w_0 \leq x \leq w_0 \text{;} \\ 0, & \text{elsewhere,} \end{cases}
\]

where \( A_{2n} \) is the normalization constant. In order that reflected beam profiles calculated for a polynomial-type incident beam can be compared to those for Gaussian beams, \( A_{2n} \) will be normalized according to

\[
A_{2n} \int_{-w_0}^{w_0} [1 - (x/w_0)^2]^2 dx = \int_{-w_0}^{w_0} |U_g| dx
\]

where \( U_g(x, 0) \) is the Gaussian incident distribution given by

\[
U_g(x, 0) = \exp \left[ - (x/w_0)^2 \right] \text{.}
\]

Evaluation of the right-hand side of (3) yields

\[
\int_{-w_0}^{w_0} |U_g|^2 dx = (\pi/2)^{1/2} w_0 \text{ erf } (\sqrt{2})
\]

where \( \text{erf}(x) \) is the Gaussian error function and the function \( \text{erf}(x) \) is defined by

\[
erf(x) = \frac{2}{(\pi)^{1/2}} \int_0^x \exp (-t^2) dt
\]

Combination of (3) and (5) gives the normalization constants \( A_{2n} \) up to the sixth order as

\[
A_0 = 0.7734, \quad A_2 = 1.0590, \quad A_4 = 1.2132, \quad A_6 = 1.3243
\]

The normalized intensity profiles of the even-ordered polynomial incident beams and the Gaussian intensity profile are presented in Fig. 1 for comparison. It is noted that the analysis of the general even-ordered polynomial beams also includes the special case of a piston source, where \( n = 0 \).

In order to evaluate the reflected or transmitted sound field from (1), one needs to determine \( V(k_x) \) from the polynomial incident profile given by (2). This results in

\[
V_{2n}(\alpha) = 2w_0 \sum_{m=0}^{n} a_{mn} \left[ \frac{\sin \alpha m}{\alpha} \sum_{p=0}^{m} \frac{b_{mp}}{\alpha^{2p}} \right] + \frac{\cos \alpha}{\alpha} \sum_{q=1}^{m} \frac{c_{mq}}{\alpha^{2q-1}} \quad \text{for } \alpha \neq 0
\]

where \( b_{mp} = (-1)^p (2m + 1) \)

\[
a_{mn} = \frac{(-1)^n n! (m+1)!}{(2n+1)!} \quad \text{for } m = 0, 1, 2, \ldots, n
\]

\[
b_{mp} = (-1)^p (2m + 1) \quad \text{for } p = 0, 1, 2, \ldots, m
\]

\[
c_{mp} = \frac{(-1)^{m+1}}{(2m + 1)!} \quad \text{for } q = 0, 1, 2, \ldots, m
\]
Evaluation of the integral in (1) to determine the reflected or transmitted sound field is now possible since \( V(k_x) \) has been determined and the plane wave reflection or transmission coefficient \( P(k_x) \) for several layered media is well established [5].

**Computational Results**

The nonspecular effects for an incident beam having an even-ordered polynomial profile are illustrated here for the simple case of a bounded beam reflected from a liquid-solid interface. Calculations are performed for the Rayleigh critical angle of a water-stainless steel interface and for the longitudinal critical angle of a water-Plexiglas structure.

In Fig. 2, the nonspeculatively reflected beam profile at the Rayleigh angle is presented for both types of incident profiles. In the well-known case of a Gaussian profile, the reflected profile shows the familiar two peaks with a trailing field on both sides of the beam. However, reflected profiles associated with the even-ordered polynomial incident beam all exhibit distinct sidelobes in place of the trailing field. Among profiles of different orders, the profiles of lower orders have a higher reflection intensity level as measured by the magnitude of the two principal peaks. In general, one observes that the polynomial description of the incident beam does not change the fundamental nonspecular features other than the appearance of the sidelobes.

For the water-Plexiglas interface, nonspecular effects are investigated for the longitudinal critical angle. Results of an earlier study [3] for a Gaussian incident beam only showed the nonspecular feature of a lateral displacement. For the case of polynomial incident beams the nonspecularly reflected beams for all orders considered are again characterized by a lateral displacement of approximately the same magnitude. Sidelobes, although discernable but very small, are also present on both sides of the main peak. These results are illustrated in Fig. 3. The appearance of sidelobes in both sets of calculations is definitely associated with the choice of an nth-ordered polynomial for the incident beam distribution. For such a distribution, decomposition of the incident beam into plane waves as represented by its Fourier transform \( V_{im}(a) \) shows contributions from plane waves deviating considerably from the central direction are quite significant and vary according to \( \sin \alpha/a \) or \( \cos \alpha/a \). As a result, the trailing field which always exists in the case of a Gaussian incident profile is no longer present and sidelobes are introduced into the reflected profiles.

**Conclusion**

The description of a finite incident beam by an even-ordered polynomial has been shown to lead to a new nonspecular feature in the reflected beam profile. The computational results predict that upon reflection at the critical angles associated with layered media, sidelobes will appear in the reflected profile if the incident beam has a polynomial distribution instead of a Gaussian one. The present study can form a basis for investigations of nonspecular reflection or transmission of an incident beam having an arbitrary intensity distribution which can be modeled through polynomial fitting.

**References**


